S	eard	ch No	ites	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,368	YUN ET AL.	
Examiner	Art Unit	
Scott M. Getzow	3762	

SEARCHED					
Class	Subclass	Date	Examiner		
ydet	eQ.	7/24/06	S		
		-			
	<del></del>				

INTERFERENCE SEARCHED					
Examiner					
56					
. <del></del> .					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
	-	
	:	
	: :	
		1
,		
	•	